Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,533	HWANG ET AL.	
Examiner	Art Unit	
Steven H. Rao	2814	

	SEARCHED					
Class	Subclass	Date	Examiner			
438	210	1/23/2007	SR			
438	255	1/23/2007	SR			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
438	210	1/23/2007	SR			
438	255	1/23/2007	SR			
(storage with node) and semiconductor and (SAC or (self w		1/23/2007	SR			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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